Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/596,590	ONOUE ET AL.	
Examiner	Art Unit	
Karuna P. Reddy	1713	

	SEARCHED		
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH N (INCLUDING SEARC)
	DATE	EXMR
EAST, Inventor's Search	7/11/2007	KR
524/800,801	7/12/2007	KR
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